


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/711,262	OKUBO ET AL.	
	Examiner	Art Unit	
	Derek S. Chapel	2872	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference Search (see attached)		2/24/2006	DSC

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Class/Subclass search: 359/1,4,5,6,7,490,492,494,495,497,500,577,652,653,654 (text only, see attached)	2/13/2006	DSC
Class/Subclass search: 430/1,2; 252/582,585; 427/162,163.1 (text only, see attached)	2/13/2006	DSC
NPL search (INSPEC, see attached)	2/14/2006	DSC
Consulted with Arnel Lavarias about the claims and search	2/13/2006	DSC
PLUS search	2/13/2006	DSC